

MOSFET – Power, Single, N-Channel 40 V, 0.80 m Ω , 330 A

NTMFS5H400NL

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	40	V
Gate-to-Source Voltage	€		V_{GS}	±20	٧
Continuous Drain		T _C = 25°C	I _D	330	Α
Current R _{θJC} (Notes 1, 3)	Steady	T _C = 100°C		210	
Power Dissipation	State	T _C = 25°C	P_{D}	160	W
R _{θJC} (Note 1)		T _C = 100°C		66	
Continuous Drain		T _A = 25°C	I _D	46	Α
Current R _{θJA} (Notes 1, 2, 3)	Steady State	T _A = 100°C		29	
Power Dissipation		T _A = 25°C	P_{D}	3.3	W
R _{θJA} (Notes 1 & 2)		T _A = 100°C		1.3	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	900	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to + 150	°C
Source Current (Body Diode)			I _S	180	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 49 A)			E _{AS}	360	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

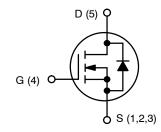
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

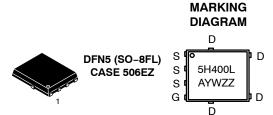
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.76	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	38	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	$0.80~\text{m}\Omega$ @ $10~\text{V}$	330 A
40 V	1.1 mΩ @ 4.5 V	330 A



N-CHANNEL MOSFET



5H400L = Specific Device Code A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

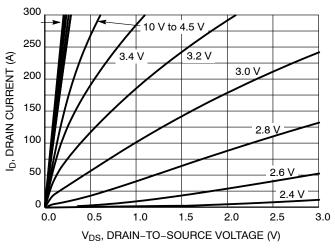
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				11.9		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25 °C			10	
		V _{DS} = 40 V	T _J = 125°C			250	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 4)					•		
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.2		2.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-4.8		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 50 A		0.60	0.80	
		V _{GS} = 4.5 V	I _D = 50 A		0.85	1.1	mΩ
Forward Transconductance	9FS	V _{DS} =15 V, I _D	₎ = 50 A		350		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 20 V			7700		
Output Capacitance	C _{OSS}				1800		pF
Reverse Transfer Capacitance	C _{RSS}				87		
Output Charge	Q _{OSS}	V _{GS} = 0 V, V _{DD} = 20 V			80		nC
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 20 V; I _D = 50 A			54		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 20 V; I _D = 50 A			120		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 20 V; I _D = 50 A			11		nC V
Gate-to-Source Charge	Q _{GS}				20		
Gate-to-Drain Charge	Q_GD				13		
Plateau Voltage	V_{GP}				2.7		
SWITCHING CHARACTERISTICS (Note 5	5)						
Turn-On Delay Time	t _{d(ON)}				20		
Rise Time	t _r	Voc = 4.5 V. Vr	oc = 20 V.		140		ns
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 4.5 V, V_{D} I_{D} = 50 A, R_{G}	$= 2.5 \Omega$		51		
Fall Time	t _f	1			17		1
DRAIN-SOURCE DIODE CHARACTERIS	TICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.76	1.2	
		$V_{GS} = 0 \text{ V},$ $I_{S} = 50 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$		0.6		V	
Reverse Recovery Time	t _{RR}		1		66		
Charge Time	t _a	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 50 \text{ A}$			35		ns
Discharge Time	t _b				31		
Reverse Recovery Charge	Q _{RR}				100		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

^{5.} Switching characteristics are independent of operating junction temperatures.

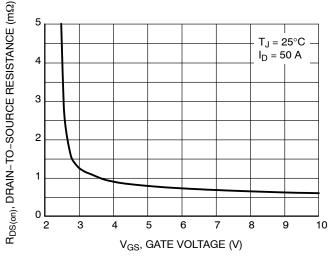
TYPICAL CHARACTERISTICS



300 275 250 ID, DRAIN CURRENT (A) 225 200 175 150 125 $T_J = 25^{\circ}C$ 100 75 50 $T_{\rm J} = 125^{\circ}$ -55°C 25 0 0.5 1.5 2.5 3.5 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



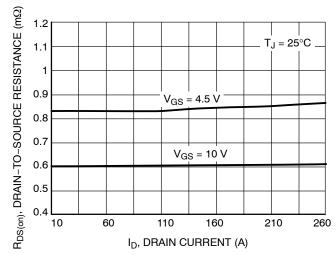
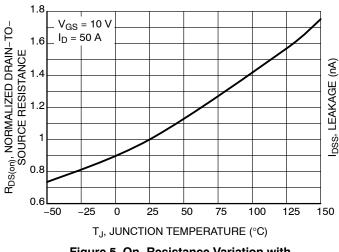


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



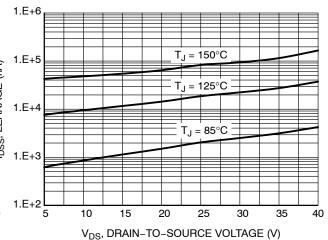


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

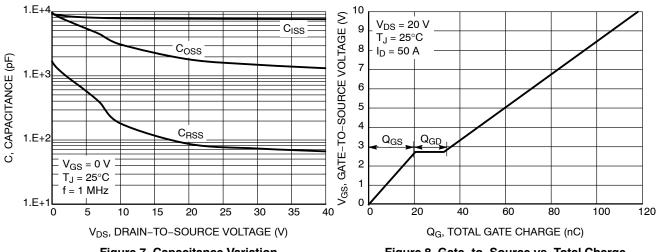


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge

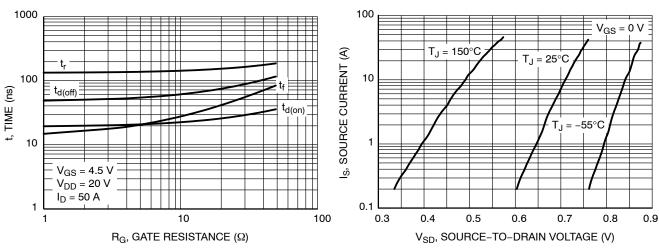


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

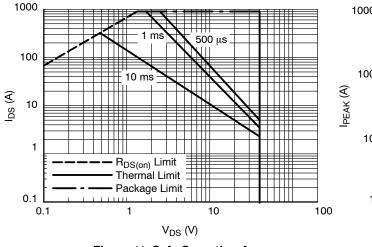


Figure 11. Safe Operating Area

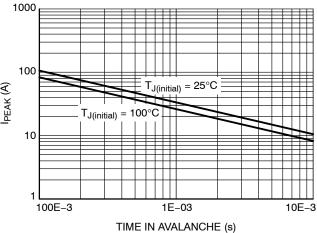


Figure 12. I_{PEAK} vs. Time in Avalanche

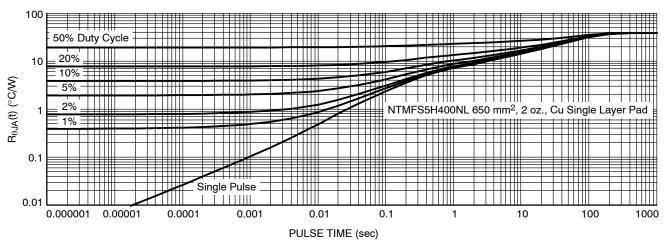


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTMFS5H400NLT1G	5H400L	DFN5 (Pb-Free)	1500 / Tape & Reel
NTMFS5H400NLT3G	5H400L	DFN5 (Pb-Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



В

DATE 25 AUG 2021



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
 2. CONTROLLING DIMENSION: MILLIMETERS
 3. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

		MI	LLIMETER	25
PIN 1 IDENTIFIER E1 E E1 E	DIM	MIN.	N□M.	MAX.
PIN 1 IDENTIFIER E1 E	Α	0.90	1.00	1.10
	A1	0.00		0.05
	b	0.33	0.41	0.51
	С	0.23	0.28	0.33
A1. 1 C	D	5.00	5.15	5.30
TOP VIEW DETAIL A SEATING	D1	4.70	4.90	5.10
I DI VILW	D2	3.80	4.00	4.20
DETAIL A —	E	6.00	6.15	6.30
// 0.10 C	E1	5.70	5.90	6.10
	E2	3.45	3.80	3.85
□ 0.10 C	е		1.27 BSC	
SIDE VIEW E SEATING	G	0.51	0.575	0.71
OIDE VIEW ENGINE	k	1.10	1.20	1.40
8X b	L	0.51	0.575	0.71
0.10 CAB	L1		0.125 RE	F
	М	3.00	3.40	3.80
	θ	0*		12*
	0.4950-	4.5	56	
L-	1	2× 1.53-		
PACKAGE	x 0.25	 		3.20

GENERIC MARKING DIAGRAM*

DUTLINE

2X 0.91

0.97

4X 1.00

4X 0.75-



RECOMMENDED MOUNTING FOOTPRINT

_ 1.27 PITCH

For additional information on our Pb-Free strategy and soldering details, please download the IN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

Α	= Assembly Location
Υ	= Year
W	= Work Week
ZZ	Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■" may or may not be present. Some products may not follow the Generic Marking.

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BOTTOM VIEW

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